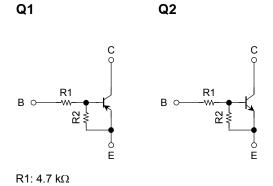
TOSHIBA Transistor Silicon PNP · NPN Epitaxial Type (PCT Process) (Bias Resistor Built-in Transistor)

RN4906FE

Switching, Inverter Circuit, Interface Circuit and **Driver Circuit Applications**

- Two devices are incorporated into an Extreme-Super-Mini (6-pin) package.
- Incorporating a bias resistor into a transistor reduces parts count. • Reducing the parts count enables the manufacture of ever more compact equipment and lowers assembly cost.

Equivalent Circuit and Bias Resistor Values



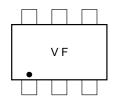
1.6±0.05 1.2±0.05 0.5 6 I.0±0.05 .6±0.05 0.2±0.05 5 0.5 2 22 0.55±0 0.12±0.05 (E1) (B1) 1. EMITTER1 2. BASE1 3. COLLECTOR2 (C2) 4. EMITTER2 (E2) 5. BASE2 (B2) 6. COLLECTOR1 (C1) ES6 JEDEC _ JEITA _ TOSHIBA 2-2N1G

Weight: 0.003g (typ.)

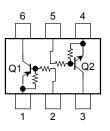
Marking

R2: 47 kΩ

(Q1, Q2 common)



Equivalent Circuit (top view)



Unit: mm

Maximum Ratings (Ta = 25°C) (Q1)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	-50	V
Collector-emitter voltage	V _{CEO}	-50	V
Emitter-base voltage	V _{EBO}	-5	V
Collector current	Ι _C	-100	mA

Maximum Ratings (Ta = 25°C) (Q2)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	50	V
Collector-emitter voltage	V _{CEO}	50	V
Emitter-base voltage	V _{EBO}	5	V
Collector current	Ι _C	100	mA

Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Collector power dissipation	P _C (Note)	100	mW
Junction temperature	Тj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Total rating

Electrical Characteristics (Ta = 25°C) (Q1)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = -50 \text{ V}, \ I_E = 0$	_		-100	nA
	ICEO	$V_{CE}=-50~V,~I_B=0$	_	_	-500	
Emitter cut-off current	I _{EBO}	$V_{EB}=-5~V,~I_C=0$	-0.074	_	-0.138	mA
DC current gain	h _{FE}	$V_{CE} = -5 \text{ V}, \text{ I}_{C} = -10 \text{ mA}$	80	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_{C} = -5 \text{ mA}, I_{B} = -0.25 \text{ mA}$	_	-0.1	-0.3	V
Input voltage (ON)	V _{I (ON)}	$V_{CE}=-0.2 \ V, \ I_C=-5 \ mA$	-0.7	_	-1.3	V
Input voltage (OFF)	VI (OFF)	$V_{CE} = -5 \text{ V}, \text{ I}_{C} = -0.1 \text{ mA}$	-0.5	_	-0.8	V
Transition frequency	f _T	$V_{CE} = -10 \text{ V}, \text{ I}_{C} = -5 \text{ mA}$	_	200	_	MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		3	6	pF

Electrical Characteristics (Ta = 25°C) (Q2)

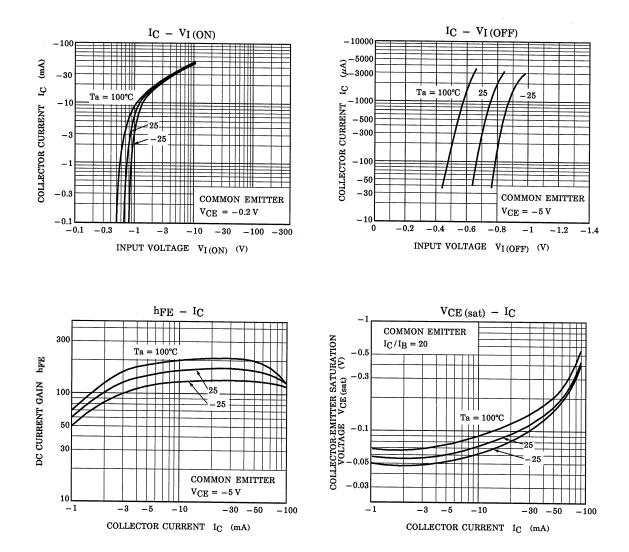
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB}=50~V,~I_{E}=0$		_	100	nA
	ICEO	$V_{CE}=50~V,~I_B=0$	_	_	500	IIA IIA
Emitter cut-off current	I _{EBO}	$V_{EB}=5~V,~I_C=0$	0.074	_	0.138	mA
DC current gain	h _{FE}	$V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}$	80	_	-	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_{C} = 5 \text{ mA}, I_{B} = 0.25 \text{ mA}$	_	0.1	0.3	V
Input voltage (ON)	V _{I (ON)}	$V_{CE}=0.2~V,~I_C=5~mA$	0.7	_	1.3	V
Input voltage (OFF)	VI (OFF)	$V_{CE} = 5 \text{ V}, I_{C} = 0.1 \text{ mA}$	0.5	_	0.8	V
Transition frequency	f _T	$V_{CE} = 10 \text{ V}, \text{ I}_{C} = 5 \text{ mA}$		250	-	MHz
Collector output capacitance	C _{ob}	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		3	6	pF

Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	—	3.29	4.7	6.11	kΩ
Resistor ratio	R1/R2		0.09	0.1	0.11	

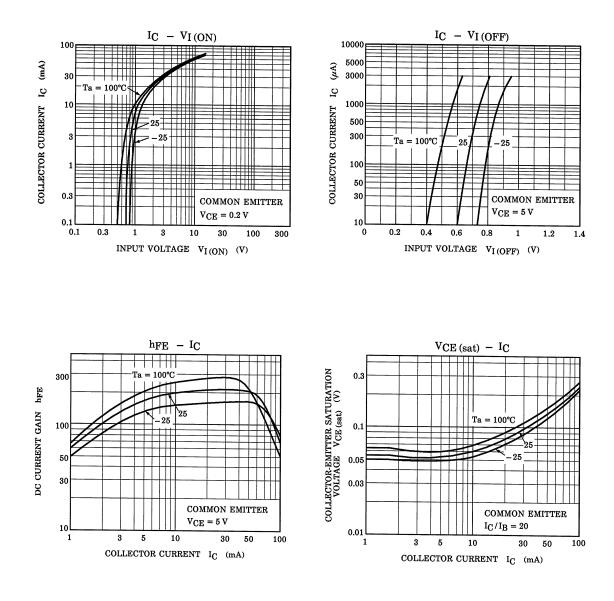
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Q1



TOSHIBA

Q2



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